

Refine Search

Search Results -

Terms	Documents
L12 and L13	8

Database:

US Pre-Grant Publication Full-Text Database
 US Patents Full-Text Database
 US OCR Full-Text Database
 EPO Abstracts Database
 JPO Abstracts Database
 Derwent World Patents Index
 IBM Technical Disclosure Bulletins

Search:

L14

Refine Search

Recall Text

Clear

Interrupt

Search History

DATE: Friday, October 27, 2006 [Purge Queries](#) [Printable Copy](#) [Create Case](#)

Set Name Query

side by side

Hit Count Set Name

result set

DB=PGPB,USPT,EPAB,JPAB,DWPI,TDBD; PLUR=YES; OP=OR

<u>L14</u>	l12 and L13	8	<u>L14</u>
<u>L13</u>	711/\$.ccls.	31413	<u>L13</u>
<u>L12</u>	l1 with l6	41	<u>L12</u>
<u>L11</u>	l8 and L10	2	<u>L11</u>
<u>L10</u>	(l4 or l5) near3 l9	9460	<u>L10</u>
<u>L9</u>	segment	754852	<u>L9</u>
<u>L8</u>	l6 and L7	68	<u>L8</u>
<u>L7</u>	l2 near4 l1	1960	<u>L7</u>
<u>L6</u>	(l3 or l4) near3 l5	7432	<u>L6</u>
<u>L5</u>	index or indices	1667547	<u>L5</u>
<u>L4</u>	map\$	487775	<u>L4</u>
<u>L3</u>	translat\$	537220	<u>L3</u>
<u>L2</u>	search\$	506806	<u>L2</u>
<u>L1</u>	cam or (content adj addressable adj memory)	460859	<u>L1</u>



Welcome United States Patent and Trademark Office

☐ Search Session History
[BROWSE](#)[SEARCH](#)[IEEE XPLORE GUIDE](#)

Edit an existing query or
compose a new query in the
Search Query Display.

Fri, 27 Oct 2006, 4:54:00 PM EST

Search Query Display

Select a search number (#)
to:

- Add a query to the Search Query Display
- Combine search queries using AND, OR, or NOT
- Delete a search
- Run a search

Recent Search Queries

- #1 ((cam <or> (content addressable memory))<in>metadata)
- #2 (((((cam <or> (content addressable memory))<in>metadata))<AND>(index or indices<in>metadata)))
- #3 ((((((cam <or> (content addressable memory))<in>metadata))<and>(index or indices<in>metadata)))<AND>(map* <or> transl* <in>metadata)))
- #4 (((((((cam <or> (content addressable memory))<in>metadata))<and>(index or indices<in>metadata)))<and>(map* <or> transl* <in>metadata)))<AND>(independent<in>metadata)))



Indexed by
 Inspec[®]

[Help](#) [Contact Us](#) [Privacy &](#)

© Copyright 2006 IEEE –